

Notice of References Cited	Application/Control No. 10/551,925	Applicant(s)/Patent Under Reexamination HONMA, TOSHIHIKO	
	Examiner Quyen P. Leung	Art Unit 2874	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,025,239	04-2006	Itano et al.	225/95
*	C	US-2005/0169594	08-2005	Song, Jae Seop	385/134
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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